

FORM PTO-1449

US DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

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To be Assigned

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Applicant:

Barry D. Silverstein, et al

LIST OF ART CITED BY APPLICANT

(Use several sheets if necessary)

Filing Date

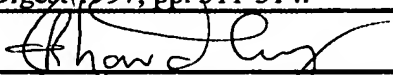
Herewith 03/30/2004

Group

28 71
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U.S. PATENT DOCUMENTS

Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.R.C.	4,441,791	4/10/84	Hornbeck	359	295	
	5,535,047	7/9/96	Hornbeck	359	295	
	5,600,383	2/4/97	Hornbeck	348	771	
	5,719,695	2/17/98	Heimbuch	359	291	
	5,914,818	6/22/99	Tejada et al.	359	663	
	5,930,050	7/27/99	Dewald	359	670	
	6,008,951	12/28/99	Anderson	359	677	
	6,089,717	7/18/00	Iwai	353	31	
	5,808,795	9/15/98	Shimomura et al.	359	488	
	5,798,819	8/25/98	Hattori et al.	353	33	
	5,918,961	7/6/99	Ueda	353	20	
	6,010,121	1/4/00	Lee	269	94	
	6,062,694	5/16/00	Oikawa et al.	353	31	
	5,652,667	7/29/97	Kurogane	349	42	
	5,767,827	6/16/98	Kobaysashi et al.	345	87	
	5,978,056	11/2/99	Shintani et al.	349	137	
	5,620,755	4/15/97	Smith, Jr. et al.	428	121	
	2,403,731	7/9/46	MacNeille	359	488	
	5,969,861	10/19/99	Ueda et al.	359	488	
	5,912,762	6/15/99	Li et al.	359	352	
	5,844,722	12/1/98	Stephens et al.	359	637	
	5,383,053	1/17/95	Hegg et al.	359	426	
	5,748,368	5/5/98	Tamada et al.	359	426	
	6,122,103	9/19/00	Perkins et al.	359	486	
	6,243,199 B1	6/5/01	Hansen et al.	359	486	
	6,288,840 B1	9/11/01	Perkins et al.	359	486	
	6,234,634 B1	5/22/01	Hansen et al.	353	20	
	4,701,028	10/20/87	Clerc et al.	349	98	
	5,039,185	8/13/91	Uchida et al.	349	119	
	5,298,199	3/29/94	Hirose et al.	264	216	
	6,081,312	6/27/00	Aminaka et al.	349	118	
	6,141,075	10/31/00	Ohmuro et al.	349	130	
	5,576,854	11/19/96	Schmidt et al.	349	5	
	5,619,352	4/8/97	Koch et al.	349	89	
	6,585,378	7/1/03	Kurtz et al.	353	31	
	5,196,953	3/23/93	Yeh et al.	349	119	
	5,548,427	8/20/96	May	349	117	

FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
T.R.C.	J. Chen, K. H. Kim, J. J. Jyu, and J. H. Souk; Optimum Film Compensation Modes for TN and VA LCDs; SID 98 Digest, pages 315-318.					
	P. Yeh; Generalized Model for Wire Grid Polarizers; SPIE Vol. 307, 1981, pages 13-21.					
	H. Kikuta, H. Yoshida, and K. Iwata; Ability and Limitation of Effective Medium Theory for Subwavelength Gratings; Optical Review, Vol. 2, No. 2 (1995), pages 92-99.					
	J. J. Kuta, H. M. van Driel, D. Landheer, and Y. Feng; Coupled-Wave Analysis of Lamellar Metal Transmission Gratings for the Visible and the Infrared; Optical Society of America, Vol. 12, No. 5 (May 1995), pages 1118-1127.					
	P. Lazarev and M. Paukshto; Low-Leakage Off-Angle in E-Polarizers; SID 2001 Digest, pages 101-105.					
	T. Ishinabe, T. Miyashita, and T. Uchida; Novel Wide Viewing Angle Polarizer with High Achromaticity; SID 00 Digest, pages 1094-1097.					
	S. Roosendaal, B. van der Zande, A. Nieuwkerk, C. Renders, J. Osenga, C. Doornkamp, E. Peeters, J. Bruinink, and J. van Haaren; Novel High Performance Transflective LCD with a Patterned Retarder; SID 03 Digest, pages 78-81.					
	B. van der Zande, A. Nieuwkerk, M. van Deurzen, C. Renders, E. Peeters, and S. Roosendaal; Technologies Towards Patterned Optical Foils; SID 03 Digest, pages 194-197.					
	H. Seiberle, C. Benecke, and T. Bachels; Photo-Aligned Anisotropic Optical Thin Films; SID 03 Digest, pages 1162-1165.					
↓	Y. Iimura and S. Kobayashi; Prospects of the Photo-Alignment Technique for LCD Fabrication; SID Digest 1997; pp. 311-314.					
EXAMINER 			DATE CONSIDERED 12/14/05			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						